Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/658,202	MOCHIZUKI, AKIRA
Examiner	Art Unit
Binh C. Tat	2825

			•						
SEARCHED									
Class	Subclass	Date	Examiner						
716	1	1/19/2007	вт						
365	230.05	1/19/2007	ВТ						
	-								

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	,				

SEARC (INCLUDING SE	H NOT ARCH	ES STRATEGY)
		DATE	EXMR
EAST SEARCH		1/19/2007	ВТ
	:		
			1.0
		_	
	-		_